## Notice of References Cited

Applicant(s)/Patent Under Application/Control No. Reexamination YAMANE, TAKESHI 09/867,565 Art Unit Examiner Page 1 of 1 1714 Katarzyna Wyrozebski Lee

**U.S. PATENT DOCUMENTS** 

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
А	US-4,918,116	04-1990	Gardziella et al.	523/149
В	US-			
С	US-			
D	US-			
E	US-			
F	US-			
G	US-			
Н	US-			
ı	US-			
J	US-			
к	US-			
L	US-			
М	US-			

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.